

**CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on November 14, 2003..

Signed:

*Kimberly Melvin*  
Kimberly Melvin

**PATENT**



**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of:

WANG, Youqi et al.

Application No.: 10/642,386

Filed: August 15, 2003

For: ELECTROCHEMICAL SCREENING SYSTEM

Atty. Docket No.: SYMXP010

Examiner: Unassigned

Group: Unassigned

Date: November 14, 2003

**INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR §§1.56 AND 1.97(c)**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

The references listed in the attached PTO Form 1449, copies of which are attached, may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§1.56 and 1.97. The Examiner is requested to make these references of official record in this application.

This Information Disclosure Statement is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

This Information Disclosure Statement is believed to be filed before the mailing date of a first Office Action on the merits. Accordingly, it is believed that no fees are due in connection with the filing of this Information Disclosure Statement. However, if it is determined that any fees are due, the Commissioner is hereby authorized to charge such fees to Deposit Account 50-1652 (Order No. SYMXP010).

Respectfully submitted,

*Cindy S. Kaplan*

Cindy S. Kaplan  
Reg. No. 40,043

RITTER, LANG & KAPLAN LLP  
12930 Saratoga Ave., Suite D1  
Saratoga, CA 95070  
(408) 446-8690

## Form 1449 (Modified)

Information Disclosure  
Statement By Applicant

(Use Several Sheets if Necessary)

Atty Docket No. SYMXP010  
 Application No. 10/642,386  
 Inventor WANG, Youqi et al.  
 Group Unassigned  
 Filing Date August 15, 2003  
 Mailing Date November 14, 2003

## U.S. Patent and Published Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-Class	Filing Date
	A	4,956,067	09/1990	Yun et al.	204	212	1/4/1990
	B	5,985,356	11/1999	Schultz et al.	427	8	10/18/1994
	C	6,045,671	04/2000	Wu et al.	204	298.11	4/22/1997
	D	6,187,164	02/2001	Warren et al.	205	81	7/20/1998
	E	6,364,956	04/2002	Wang et al.	118	726	1/26/1999
	F	6,455,316	09/2002	Turner et al.	436	37	4/13/2000
	G	6,468,806	10/2002	McFarland et al.	436	518	9/30/1997

## Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	H	WO 98/14641	4/9/1998	WO				
	I	WO 00/17413	3/30/2002	WO				
	J	WO 02/48841	6/20/2002	WO				

## Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	K	Schmidt et al., "Rotating Disk Electrode Measurements on the CO Tolerance of a High-Surface Area Pt/Vulcan Carbon Fuel Cell Electrocatalyst," Journal of the Electrochemical Society (1999), 146(4), 1296-1304
	L	Schmidt et al., "Characterization of High-Surface-Area Electrocatalysts Using a Rotating Disk Electrode Configuration" Journal of the Electrochemical Society (1998), 145(7), 2354-2358
	M	"Rotating Disk Electrode for Voltammetry" Metrohm Ltd, Metrohm Ion Analysis, December 1995
	N	"BAS RDE-2 Rotating Disk Electrode" <a href="http://www.bioanalytical.com/products/ec/rde-2.html">wysiwyg://12/http://www.bioanalytical.com/products/ec/rde-2.html</a> , April 15, 2003
	O	"Electrochemistry Refresher" <a href="http://www.bath.ac.uk/~chascf/java/electrochemistry/elec/17html/hydro.htm">http://www.bath.ac.uk/~chascf/java/electrochemistry/elec/17html/hydro.htm</a> ,
	P	Bard, Allen J. et al., "Electrochemical Methods, Fundamentals and Applications", Chapter 8, pp. 280-312, 1980

Examiner:

Date Considered:

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered.  
 Include copy of this form with next communication to applicant.